Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/719,192	BAEK ET AL
Examiner	Art Unit
Leila Malek	2611

SEARCHED					
Class	Subclass	Date	Examiner		
375	, 260	8/13/2007	L.M		
375	340	8/13/2007	L.M		
375	355	8/13/2007	L.M		
375	354	8/13/2007	L.M		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
				

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST	8/13/2007	Ł.M
IEEE	8/13/2007	L.M
GOOGLE	8/13/2007	L.M
Consulted M. Ghayour	8/10/2007	L.M